Processing of 24 Micron Image Data at the Spitzer Science Center

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The MIPS-24µm Detector Field of View Pixel Size λ(μm) F/# λ/Δλ QE RN Gain (') (") 5.2x5.2 2.45 20.5 - 26.5 7.4 4 60% 27e- 5e/DN

a raray was developed by Boeing and locked impurity band Si:As device. continuously and non-destructively out every 0.5 econds until reset. w pixel data is in 16-bit signed integers mary pixel data are received as slopes, on-board sample-up-the-ramp data model) tion Events (DCEs) are wo-plane FITS cubes where e image, plane2 = difference p sample2 - sample1, both in t is shown at right. PSF is actor 1.4 above Nyquist.

128x128



Spitzer downlink data flow at SSC





Pointing Transfer Flow and Post-BCD steps



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24µm Pipelines Summary

In all, there are thirteen (separate) <u>automated</u> pipeline threads for processing raw science Data Collection Events (DCEs) to produce Basic Calibrated Data images (BCDs) with pointing information:

- basic Calibration Data imagies (BCOs) with pointing information:
 SUR-mode science (P-Jane DCEs input: slope + difference)
 RAW-mode science (multi-plane DCEs: titler 6, 2, 00 r 60 plane data ramps)
 SUR-mode dark-current calibration (pre-processing)
 RAW-mode science (multi-plane information:
 RAW-mode science (multi-plane information (pre-processing)
 RAW-mode dark-current calibration (pre-processing)
 RAW-mode science (multi-plane be-processing of 5)
 Non-inearity calibration (pre-processing)
 Non-inearity calibration (pre-processing)
 RaW-mode dark-current calibration (pre-processing)
 RAW-mode dark-current calibration (pre-processing)
 Non-inearity calibration (pre-processing)
 RaW-mode dark-current calibration (pre-processing)
 Sur-inearity calibration (pre-processing)
 Sur-inearity

Special Instrumental Signatures and Algorithms "Droop" effect

Sed to each pixel by the readouts and it not well irrectly proportional to the total number of counts on the ne. The constant of proportionality (termed the "droop incally. For a droop coefficient (total number of pixels on al F_a for pixel *ij* the droop signal is given by This is a constant offse understood. This signal



of the droop effect where one half of the array was verage signal therein was plotted as a function of the account for as much as 10% of the pixel signal.



"Read-2" effect

This represents a bias introduced into the SUR mode slope measurement by a small additive offset to the second read in the ramp (the first read is automatically ignored due to known reset transients). This additive offset varies across the array and has been empirically calibrated using flight RAW-mode data. Saturation flagging

Saturated pixels are identified and flagged in a bit mask according to the following: <u>1</u>, if sample 2 – 1 difference : THRESHOLD VALUE ("Soft" saturation condition <u>2</u>, if slope – 0 and difference = 0. This can arise if the ramg gets pegged to the maximum value allowed in the A-b-D (-s0% full well) due to "immediate saturation", (Hard" saturation condition).

In processing, saturated slope pixels are replaced with the corresponding difference value to recover more correct scan rates, at the expense however of a larger uncertainty for difference values. The following shows a ramp and slope fit



n-linearity correction

Although a effect seen in all detectors, a simple algorithm as been developed for its correction (module SLOPECORR in science pipeline flow chart). The detector has been characterized by a quadtric non-linearity model:



Scan-Mirror Depedendent Flat-Fielding

MIPS 24µm DCE images have dark spots and low-level "blotchiness" due to debris on a pick-off mirror in the scan-mirror mechanism. Consequently, these spots appear to move in images according to the position of the scan-mirror in an observation. Furthermore, these spots are smeared depending on the mirror scan rate.

To correct the spotty images, high signal-to-ine flats are made for each rate. To correct the spotty images, high signal-to-ine flats are made for each can-mirror position and applied accordingly to each image. The following are examples of some scan-mirror dependent flats. The spots and blotchiness introduce a deviation of -20% from flatness.



Photometry mode flat (scan rate = 0)

Medium scan rate fla

Pointing Reconstruction & Performance

- This is a four step process, all of which are carried out in a separate pipeline thread: The 2-Hz sampled boresight pointing history telemetry file is searched for samples which fall within the effective integration time of the DCE (raw pointing history files span 12 hour blocks).
- DCE scan-mirror positions are synchronized to the boresight pointing samples
- The detector FOV-to-boresight and FOV-to-mirror Euler angle offsets are used to transform the boresight pointing history to the FOV frame.
 The 2-Hz pointing samples in the FOV frame are averaged to compute standard ICRS pointing keywords. Discritorin keywords are also attached to FITS headers in this step from a calibration file.



Absolute pointing accuracy as measured from 24µm - 2MASS (2.2µm) astrometry is <1.2 arcsec (10 radial). This is an upper limit since the scatter in this plot is expected to be dominated by source centrolding error.

Processing Status Bit Mask

A 16-bit/pixel <u>B-Mask</u> (BCD-Mask) is associated with each BCD science product. This reports a summary of the processing steps for every pixel in the BCD. Bits are defined as follows:

Archived Products and Deliverables SUR-mode science BCD product (for a processed DCE instance):

tranhead.fits (Raw DCE containing translated header with pointing)
 - bcd_main.fits (main BCD product: slope image with saturated pixels
 replaced by values from difference image).
 - uncart, bcd_main.fits (uncertainty image for main BCD image).
 - bcd_slope.fits (uncertainty image for main BCD image).
 - bcd_slope.fits (uncertainty slope image).
 - uncert, bcd_slope.fits (uncertainty slope image).
 - uncert_bcd_slope.fits (uncertainty slope image).
 - uncert_bcd_slope.fits (uncertainty slope image).
 - bmask_slope.fits (uncertainty for difference image)
 - bmask_slope.fits (uncertainty for difference image).
 - bmask_slope.fits (uncertainty f

Post BCD products (for ensemble of BCDs in a request):

- source extraction tables

- Data are defined as follows: Bit # Condition Incomplete or questionable row-droop correction (rowdroop) No row-droop correction applied (rowdroop) No row-droop correction applied (rowdroop) Hard asturated (samas) Read-2 correction could not be applied (rowdrucorr) A Correction could not be applied (rowdrucorr) Correction could not be applied (rowdrucorr) Correction could not be applied (rowdrucorr) Doop removed ing questionable value (replaced by Difference value (desatistope and satmask respectively) Difference value (desatistope and satmask respectively) File field applied using questionable value (fieltap) Radhit detection (detect_radhit) Morelinearity correction could not be computed (slopecorr) Soft saturated (satmask) Dot reserved: sign bit>

